

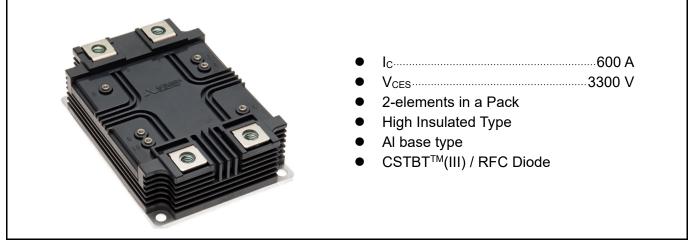
< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM600DE-66X

HIGH POWER SWITCHING USE INSULATED TYPE

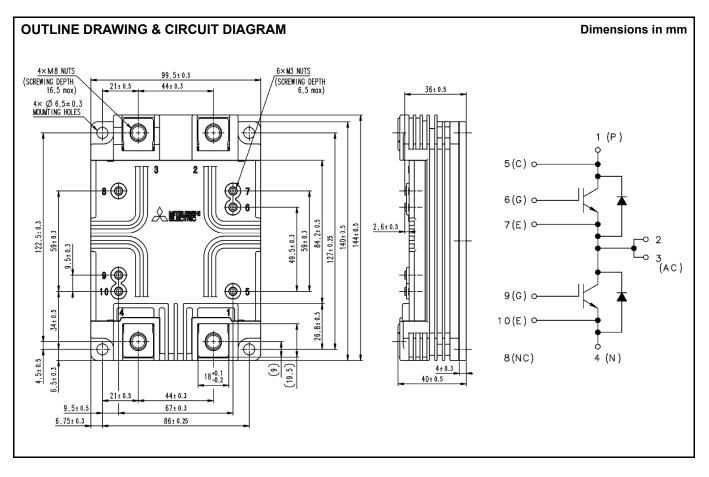
5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

CM600DE-66X



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



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MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V _{CES}	Collector-emitter voltage	V _{GE} = 0 V, T _j = -50 °C V _{GE} = 0 V, T _j = -40+150 °C	3200 3300	V
V _{GES}	Gate-emitter voltage	$V_{CE} = 0 V, T_{i} = 25^{\circ}C$	± 20	V
lc		DC, T _c = 109 °C	600	Α
ICRM	Collector current	Pulse (Note 1)	1200	А
lE	Emitter current ^(Note 2)	DC, T _c = 90 °C	600	А
I _{ERM}		Pulse (Note 1)	1200	Α
Ptot	Maximum power dissipation	T _c = 25 °C, IGBT part ^(Note 3)	6000	W
Viso	Isolation voltage	Charged part to the base-plate RMS sinusoidal, 60 Hz, 1 min., T_c = 25 °C	10200	V
Q _{PD}	Partial discharge	Charged part to the base-plate V1 = 6900 Vrms, V2 = 5100 Vrms AC 60 Hz, T_c = 25 °C (acc. to IEC 61287-1)	10	рС
Tj	Junction temperature		-50 ~ +150	°C
Tjop	Operating junction temperature	_	-50 ~ +150	°C
T _{stg}	Storage temperature	_	-55 ~ +150	°C
t _{psc}	Short circuit pulse width	$ \begin{array}{l} V_{CC} \leq 2400 \ \text{V}, \ \text{V}_{GE} = \pm 15 \ \text{V} \\ R_{G(on)} = 2.2 \ \Omega, \ R_{G(off)} = 51\Omega \\ T_{j} = T_{jop}, \ C_{GE} = 33 \ \text{nF}, \ L_{S} = 85 \ \text{nH} \end{array} $	10	μs

ELECTRICAL CHARACTERISTICS

Symbol	Itom	Conditions		Limits			Unit
Symbol	Item			Min.	Тур.	Max.	Unit
I _{CES}	Collector cutoff current	V _{CE} = V _{CES} V _{GE} = 0 V	$T_j = 25 \text{ °C}$ $T_j = 125 \text{ °C}$ $T_i = 150 \text{ °C}$		 2.0 20.0	2.0	mA
V _{GE(th)}	Gate-emitter threshold voltage	V _{CE} = 10 V, I _C = 60 mA, T _i = 2	,	— 6.5	7.0	7.5	V
	Gate leakage current	$V_{GE} = V_{GES}, V_{CE} = 0 V, T_j = 25$		-0.5		0.5	μA
IGES	Sale leakage suitem		T _i = 25 °C	0.0	2.30	0.0	μ/ (
V _{CEsat}	Collector-emitter saturation voltage	I _C = 600 A V _{GE} = 15 V ^(Note 4)	T _j = 125 °C		2.80		V
			T _j = 150 °C	—	2.90	3.30	
Cies	Input capacitance	V _{CE} = 10 V, V _{GE} = 0 V			53.4	—	
Coes	Output capacitance	$f = 100 \text{ kHz}, T_i = 25 \text{ °C}$			3.8	—	nF
Cres	Reverse transfer capacitance	1 = 100 kHz; 1j = 20 °C		—	0.5	—	
Q_{G}	Total gate charge	V _{CC} = 1800 V, I _C = 600 A V _{GE} = 15 V, T _i = 25 °C		—	3.6	—	μC
t _{d(on)}	Turn-on delay time	V _{CC} = 1800 V	T _j = 150 °C	_		1.25	μs
tr	Rise time	$l_{c} = 600 \text{ A}$	T _i = 150 °C	—		0.50	μs
	Turn-on switching energy per pulse (Note 5)	$V_{GE} = \pm 15 V$	T _j = 25 °C	_	0.98	—	
E _{on(10%)}		$\begin{array}{l} R_{G(on)} = 2.2 \ \Omega \\ C_{GE} = 33 \ nF \end{array}$	T _j = 125 °C	_	1.19	—	J
			T _i = 150 °C	—	1.20	—	
	Turn-on switching energy per pulse	L _s = 85 nH	T _j = 25 °C	_	1.05	—	
Eon		Inductive load	T _i = 125 °C	—	1.27	—	J
			T _i = 150 °C	—	1.28	—	
		n-off delay time Vcc = 1800 V	T _i = 25 °C	_	3.40	—	
t _{d(off)}	Turn-off delay time		T _i = 125 °C	_	3.60	—	μs
			T _j = 150 °C	_	3.65	5.00	-
		$I_{\rm C} = 600 {\rm A}$	T _j = 25 °C	—	0.24	—	
tr	Fall time	$V_{GE} = \pm 15 V$	T _i = 125 °C	_	0.35	—	μs
		$R_{G(off)} = 51 \Omega$	T _i = 150 °C	—	0.37	1.00)
E _{off(10%)}	Turn-off switching energy per pulse ^(Note 5)	C _{GE} = 33 nF	T _i = 25 °C	_	0.73	—	
		L _s = 85 nH	T _j = 125 °C	—	0.99	—	J
			T _j = 150 °C	—	1.00	—	
	Turn-off switching energy per pulse	Inductive load	T _j = 25 °C	—	0.83	—	
E _{off}			T _i = 125 °C	—	1.12	—	J
			T _i = 150 °C	_	1.13	_	

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ELECTRICAL CHARACTERISTICS

Symbol	ltem	Conditions		Limits			Unit
Symbol	liem			Min.	Тур.	Max.	Unit
		L 000 A	T _j = 25 °C		2.10	_	
VEC	Emitter-collector voltage (Note 2)	I _E = 600 A V _{GE} = 0 V ^(Note 4)	T _j = 125 °C		2.30	_	V
		VGE - U V V	T _j = 150 °C	—	2.40	2.90	
			T _j = 25 °C	—	0.65	_	
trr	Reverse recovery time (Note 2)		T _j = 125 °C	—	0.80		μs
			T _j = 150 °C		0.85		
	Reverse recovery current (Note 2)	$V_{CC} = 1800 V$ $I_E = 600 A$ $V_{GE} = \pm 15 V$ $R_{G(on)} = 2.2 Ω$ $C_{GE} = 33 nF$	T _j = 25 °C		970		
Irr			T _j = 125 °C		930	_	А
			T _j = 150 °C		910	_	
	Reverse recovery charge (Note 2, 6)		T _j = 25 °C		600		
Qrr(10%)			T _j = 125 °C	—	740	_	μC
			T _j = 150 °C		775	_	
			T _j = 25 °C		650	_	
Qrr	Reverse recovery charge (Note 2)	L _s = 85 nH	T _j = 125 °C		805	_	μC
			T _j = 150 °C		845		
		Inductive load	T _j = 25 °C	—	0.62	_	
Erec(10%)	Reverse recovery energy per pulse (Note 2, 5)		T _j = 125 °C		0.83		J
			T _j = 150 °C	—	0.85	_	
	Reverse recovery energy per pulse (Note 2)		T _j = 25 °C	—	0.71	_	
Erec			T _j = 125 °C		0.95	_	J
			T _j = 150 °C		0.97	_	

THERMAL CHARACTERISTICS

Symbol	Item	Conditions		Limits		
Symbol		Conditions	Min.	Тур.	Max.	Unit
Rth(j-c)Q	Thermal resistance	Junction to Case, IGBT part, 1/2 module	—	_	20.5	K/kW
Rth(j-c)D	Thermal resistance	Junction to Case, FWDi part, 1/2 module	—	_	34.0	K/kW
Rth(c-s)	Contact thermal resistance	Case to heat sink, 1/2 module $\lambda_{grease} = 1 \text{ W/m} \cdot \text{K}$, $D_{(c-s)} = 70 \mu\text{m}$	—	16.0		K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits		
				Тур.	Max.	Unit
Mt		Main terminals screw: M8	7.0	_	14.0	N∙m
Ms	Mounting torque	Mounting screw: M6		—	6.0	N∙m
Mt		Auxiliary terminals screw: M3		_	0.8	N∙m
m	Mass	—		0.75	—	kg
CTI	Comparative tracking index	—	600	_	_	
da	Clearance	—	26.0	_	_	mm
ds	Creepage distance	—	56.0	_	_	mm
LP P-N	Parasitic stray inductance	Between P-side terminal and N-side terminal		40.0	—	nH
Rcc'+ee'	Internal lead resistance	$T_c = 25 \text{ °C}, 1/2 \text{ module}$	_	0.59	_	mΩ

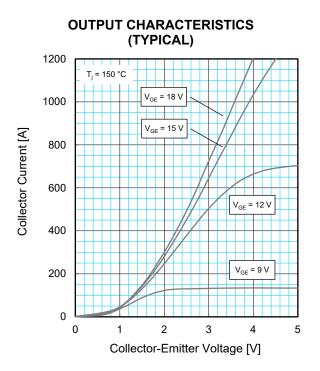
Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed maximum T_{jop} rating (150°C).

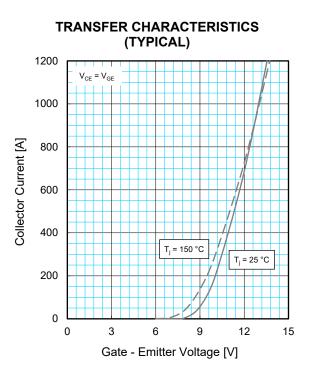
Note2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).

Note3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).

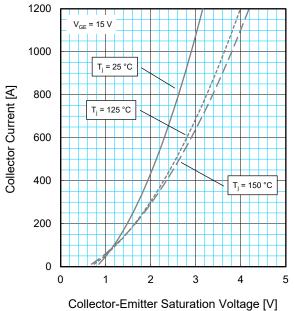
Note4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note5. The integration range of switching energies is from $10\% V_{CE}$ to $10\% I_C(I_E)$. Note6. The integration range of reverse recovery charge is from I_E =0A to $10\% I_C$

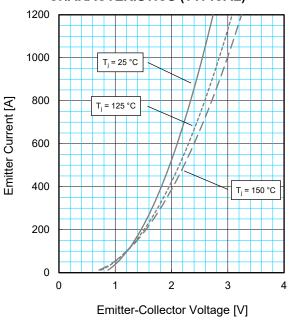


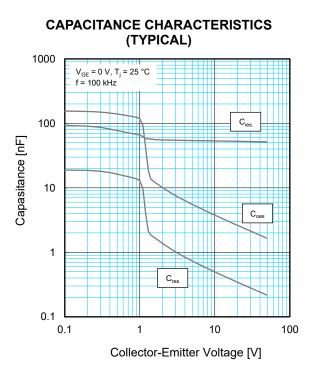


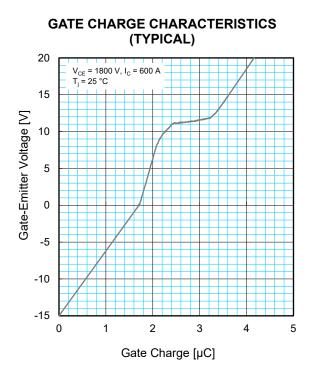
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

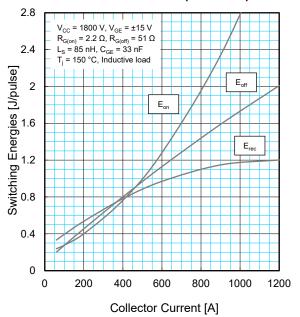


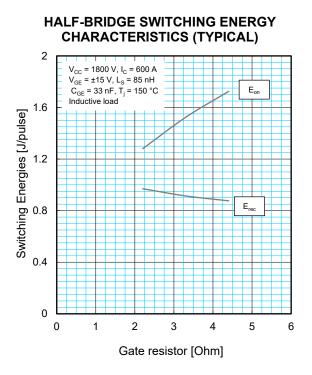


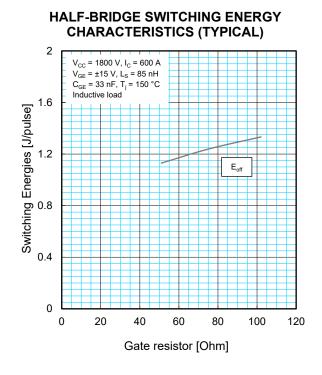


HALF-BRIDGE SWITCHING ENERGY **CHARACTERISTICS (TYPICAL)** 2.8 V_{CC} = 1800 V, V_{GE} = ±15 V $R_{G(on)} = 2.2 \Omega, R_{G(off)} = 51 \Omega$ L_S = 85 nH, C_{GE} = 33 nF 2.4 T_i = 125 °C, Inductive load Switching Energies [J/pulse] 2 Eoff Eor 1.6 E_{re} 1.2 0.8 0.4 0 0 200 400 600 800 1000 1200 Collector Current [A]

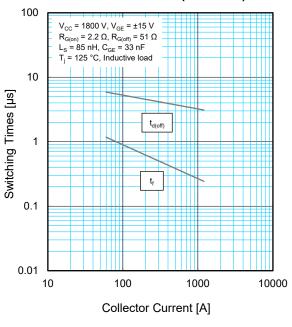
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



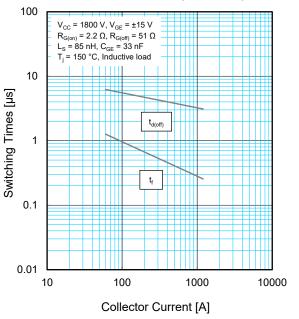


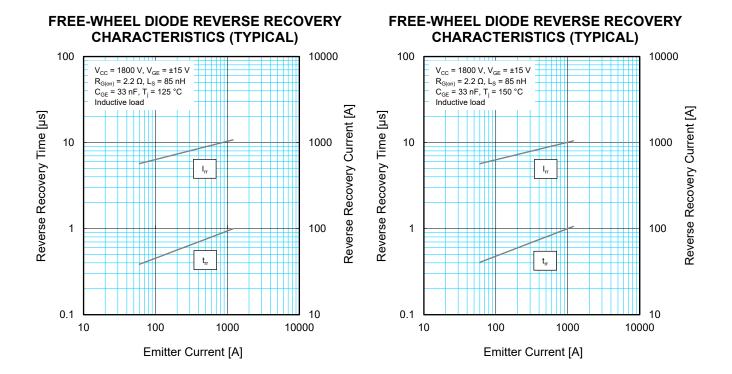


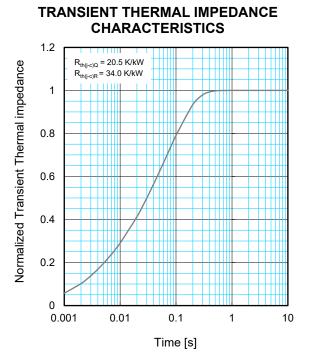
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)

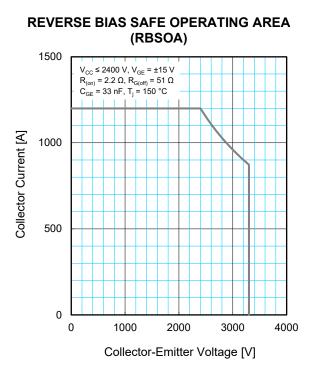


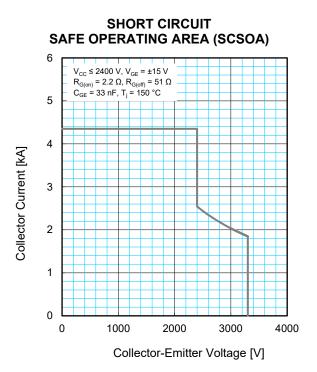




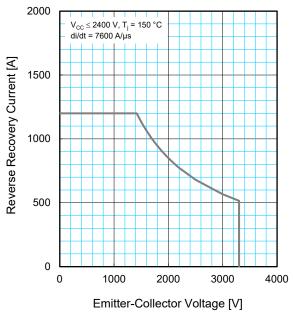
$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_i \left\{ 1 - exp^{\left(-\frac{t}{\tau_i}\right)} \right\}$$

	1	2	3	4
Ri / Rth(j-c)	0.0292	0.0832	0.2277	0.6599
τ i [s]	0.0025	0.0027	0.0155	0.0865





FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



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